Se	arch	Notes	;

Application/Control No.	Applicant(s)/Patent under Reexamination
10/645,566	JEON ET AL.
Examiner	Art Unit
Nathan Danielsen	2627

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SEARCHED				
Class	Subclass	Date	Examiner	

INI	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
:			

SEARCH NOT (INCLUDING SEARCH		)
	DATE	EXMR
Text search in class 369	7/24/2006	ND
Continued text search	7/25/2006	ND
Text search in JPO, EPO, and Derwent databases	7/25/2006	ND
Consulted Thang Tran for art	7/25/2006	ND
Continued text search in class 369	7/26/2006	ND